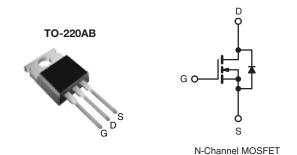


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	400				
$R_{DS(on)}(\Omega)$	$V_{GS} = 10 \text{ V}$	1.0			
Q _g (Max.) (nC)	38				
Q _{gs} (nC)	5.7				
Q _{gd} (nC)	22				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF730PbF		
Lead (FD)-lifee	SiHF730-E3		
SnPb	IRF730		
SHED	SiHF730		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	400	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Duois Current		$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		5.5		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	3.5	Α	
Pulsed Drain Current ^a			I _{DM}	22		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	290	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.5	Α	
Repetitive Avalanche Energy ^a	E _{AR}	7.4	mJ			
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	74	W	
Peak Diode Recovery dV/dt ^c	dV/dt	4.0	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s			_	300 ^d		
Mounting Toyana	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 16 mH, R_g = 25 Ω , I_{AS} = 5.5 A (see fig. 12). c. $I_{SD} \le 5.5$ A, $dI/dt \le 90$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C. d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7			

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		400	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.54	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = \	/ _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	Vo	_{SS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = 400 V, V _{GS} = 0 V		-	25	μA
<u> </u>		+	$V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$	-	-	250	, , , , , , , , , , , , , , , , , , ,
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 3.3 \text{ A}^b$	-	-	1.0	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 5$	50 V, I _D = 3.3 A ^b	2.9	-	-	S
Dynamic							
Input Capacitance	C_{iss}	\	$t_{GS} = 0 \text{ V},$	-	700	-	
Output Capacitance	C _{oss}	V	$V_{DS} = 25 \text{ V},$		170	-	pF
Reverse Transfer Capacitance	C_{rss}	f = 1.0	MHz, see fig. 5	-	64	-	
Total Gate Charge	Q_g			-	-	38	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 3.5 \text{ A}, V_{DS} = 320 \text{ V},$ see fig. 6 and 13 ^b		-	5.7	
Gate-Drain Charge	Q_{gd}			-	-	22	1 !
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 200 \text{ V, } I_D = 3.5 \text{ A}$ $R_g = 12 \Omega, R_D = 57 \Omega, \text{ see fig. } 10^b$		-	10	-	ns
Rise Time	t _r			-	15	-	
Turn-Off Delay Time	t _{d(off)}			-	38	-	
Fall Time	t _f			-	14	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	Ls			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.5	A
Pulsed Diode Forward Current ^a	I _{SM}			i	-	22	^
Body Diode Voltage	V_{SD}	$T_{J} = 25 ^{\circ}\text{C}, I_{S} = 5.5 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		1	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 3.5 A, dl/dt = 100 A/μs ^b		-	270	530	ns
Body Diode Reverse Recovery Charge	Q _{rr}			=	1.8	2.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S an				v L and	1-2)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300 \ \mu s$; duty cycle $\leq 2 \ \%$.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

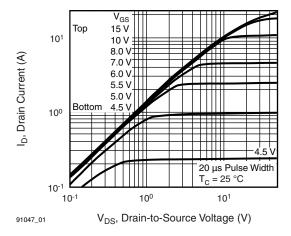


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

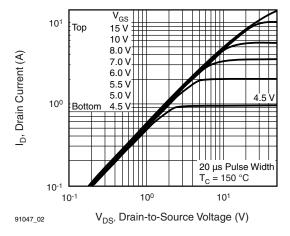


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

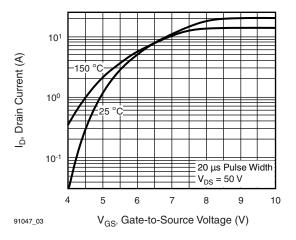


Fig. 3 - Typical Transfer Characteristics

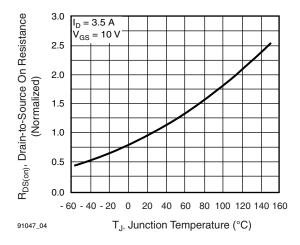


Fig. 4 - Normalized On-Resistance vs. Temperature



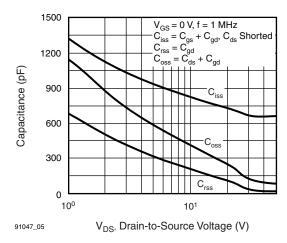


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

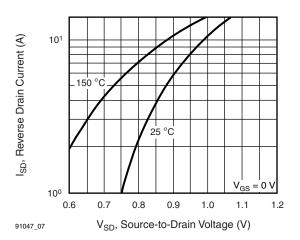


Fig. 7 - Typical Source-Drain Diode Forward Voltage

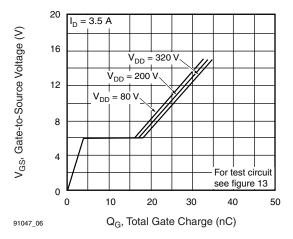


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

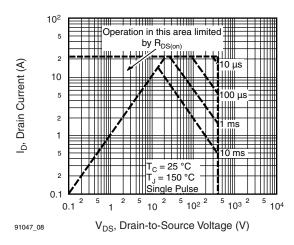
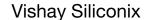


Fig. 8 - Maximum Safe Operating Area





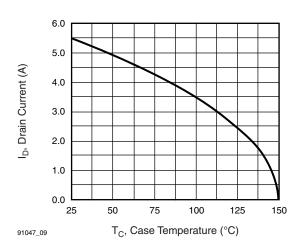


Fig. 9 - Maximum Drain Current vs. Case Temperature

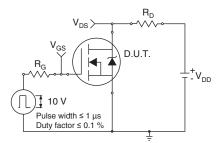


Fig. 10a - Switching Time Test Circuit

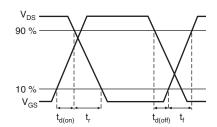


Fig. 10b - Switching Time Waveforms

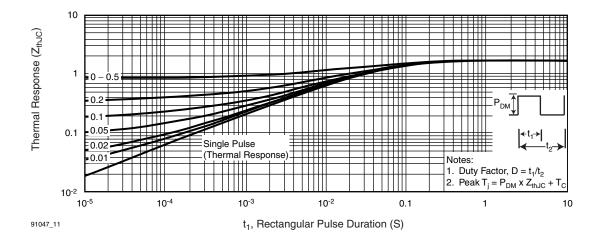


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



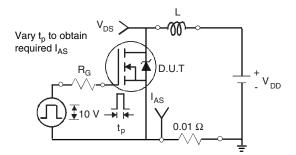


Fig. 12a - Unclamped Inductive Test Circuit

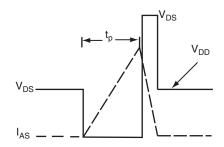


Fig. 12b - Unclamped Inductive Waveforms

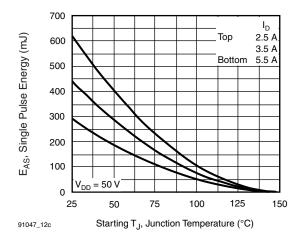


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

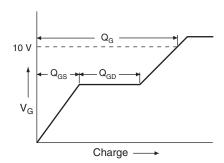


Fig. 13a - Basic Gate Charge Waveform

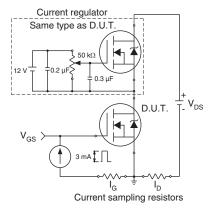
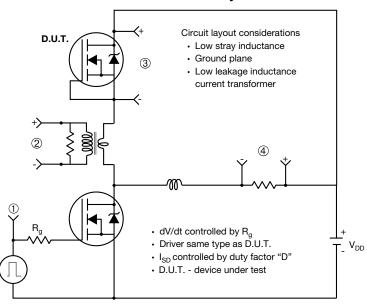


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



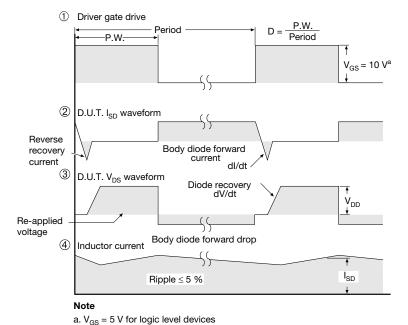
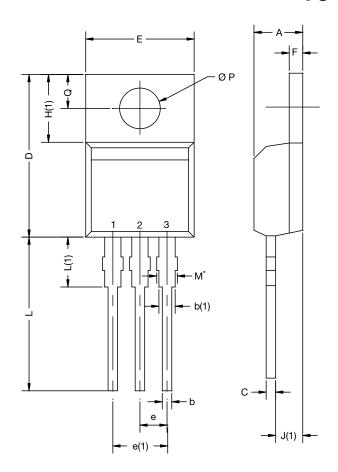


Fig. 14 - For N-Channel

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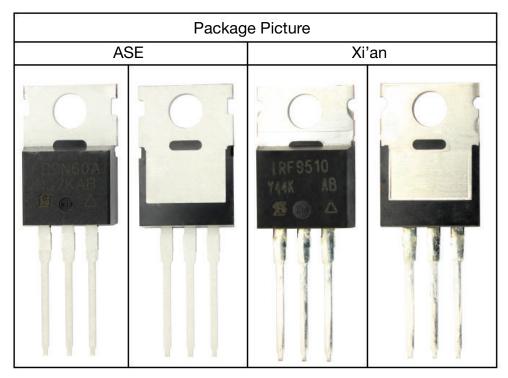
TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



Vishay

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